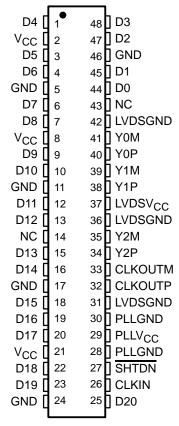
SLLS354E - MAY 1999 - REVISED JANUARY 2001

- 21:3 Data Channel Compression at up to 196 Million Bytes per Second Throughput
- Suited for SVGA, XGA, or SXGA Data Transmission From Controller to Display With Very Low EMI
- 21 Data Channels Plus Clock In Low-Voltage TTL Inputs and 3 Data Channels Plus Clock Out Low-Voltage Differential Signaling (LVDS) Outputs
- Operates From a Single 3.3-V Supply and 89 mW (Typ)
- Ultralow-Power 3.3-V CMOS Version of the SN75LVDS84. Power Consumption About One Third of the 'LVDS84
- Packaged in Thin Shrink Small-Outline Package (TSSOP) With 20 Mil Terminal Pitch
- Consumes Less Than 0.54 mW When Disabled
- Wide Phase-Lock Input Frequency Range: 31 MHz to 75 MHz
- No External Components Required for PLL
- Outputs Meet or Exceed the Requirements of ANSI EIA/TIA-644 Standard
- SSC Tracking Capability of 3% Center Spread at 50-kHz Modulation Frequency
- Improved Replacement for SN75LVDS84 and NSC's DS90CF363A 3-V Device
- Available in Q-Temp Automotive
   High Reliability Automotive Applications
   Configuration Control / Print Support
   Qualification to Automotive Standards

#### DGG PACKAGE (TOP VIEW)



NC - Not Connected

#### description

The SN75LVDS84A and SN65LVDS84AQ FlatLink transmitters contains three 7-bit parallel-load serial-out shift registers, and four low-voltage differential signaling (LVDS) line drivers in a single integrated circuit. These functions allow 21 bits of single-ended LVTTL data to be synchronously transmitted over 3 balanced-pair conductors for receipt by a compatible receiver, such as the SN75LVDS82 or SN75LVDS86/86A.

When transmitting, data bits D0 – D20 are each loaded into registers of the 'LVDS84A upon the falling edge. The internal PLL is frequency-locked to CLKIN and then used to unload the data registers in 7-bit slices. The three serial streams and a phase-locked clock (CLKOUT) are then output to LVDS output drivers. The frequency of CLKOUT is the same as the input clock, CLKIN.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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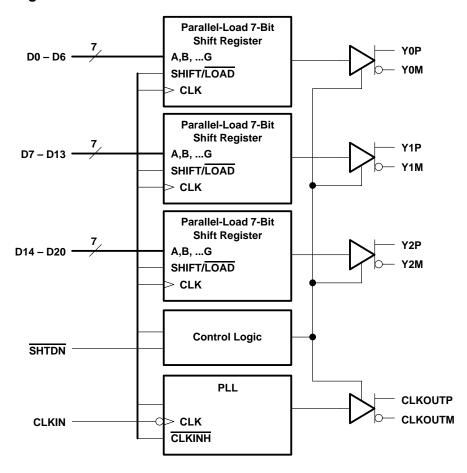
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#### description (continued)

The 'LVDS84A requires no external components and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with the data transmission transparent to the user(s). The only user intervention is the possible use of the shutdown/clear (SHTDN) active-low input to inhibit the clock and shut off the LVDS output drivers for lower power consumption. A low-level on this signal clears all internal registers to a low level.

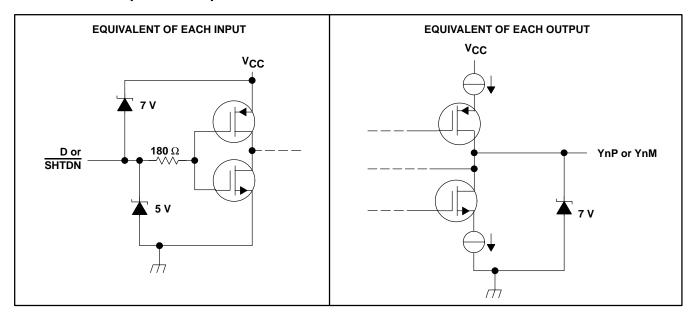
The SN75LVDS84A is characterized for operation over ambient free-air temperatures of  $0^{\circ}$ C to  $70^{\circ}$ C. The SN65LVDS84AQ is characterized for operation over the full Automotive temperature range of  $-40^{\circ}$ C to  $125^{\circ}$ C.

#### functional block diagram





# schematics of input and output



# absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

| Supply voltage range, V <sub>CC</sub> (see Note 1)            |                |
|---|----------------|
| Continuous total power dissipation                            |                |
| Operating virtual junction temperature range, T <sub>.j</sub> | –40°C to 150°C |
| Electrostatic discharge: ESD machine model                    |                |
| ESD human-body model  | 6000 V         |
| ESD charged-device model                                      |                |
| Storage temperature range, T <sub>sta</sub>                   |                |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds  |                |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the GND terminals.

#### **DISSIPATION RATING TABLE**

| PACKAGE | $T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING | DERATING FACTOR‡<br>ABOVE T <sub>A</sub> = 25°C | T <sub>A</sub> = 70°C<br>POWER RATING | T <sub>A</sub> = 125°C<br>POWER RATING |
|---------|--|---|---------------------------------------|--|
| DGG     | 1637 mW  | 13.1 mW/°C                                      | 1048 mW                               | 327 mW                                 |

<sup>‡</sup> This is the inverse of the junction-to-ambient thermal resistance when board mounted and with no air flow.

# recommended operating conditions

|  |              | MIN | NOM | MAX | UNIT |
|--|--------------|-----|-----|-----|------|
| Supply voltage, V <sub>CC</sub>                |              | 3   | 3.3 | 3.6 | V    |
| High-level input voltage, V <sub>IH</sub>      |              | 2   |     |     | V    |
| Low-level input voltage, V <sub>IL</sub>       |              |     |     | 0.8 | V    |
| Differential load impedance, Z <sub>L</sub>    |              | 90  |     | 132 | Ω    |
| Operating free air temperature T.              | SN75LVDS84A  | 0   |     | 70  | °C   |
| Operating free-air temperature, T <sub>A</sub> | SN65LVDS84AQ | -40 |     | 125 |      |



# SN75LVDS84A, SN65LVDS84AQ FLATLINK™ TRANSMITTER

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# timing requirements

|                 |   | MIN               | NOM            | MAX               | UNIT |
|-----------------|---|-------------------|----------------|-------------------|------|
| t <sub>C</sub>  | Input clock period  | 13.3              | t <sub>C</sub> | 32.4              | ns   |
| t <sub>W</sub>  | Pulse duration, high-level input clock                        | 0.4t <sub>C</sub> |                | 0.6t <sub>C</sub> | ns   |
| t <sub>t</sub>  | Transition time, input signal                                 |                   |                | 5                 | ns   |
| t <sub>su</sub> | Setup time, data, D0 – D20 valid before CLKIN↓ (see Figure 2) | 3                 |                |                   | ns   |
| th              | Hold time, data, D0 – D20 valid after CLKIN↓ (see Figure 2)   | 1.5               |                |                   | ns   |

# electrical characteristics over recommended operating conditions (unless otherwise noted)

|                     | PARAMETER   | TEST COND  | OITIONS         | MIN   | TYP† | MAX   | UNIT |
|---------------------|---|--|-----------------|-------|------|-------|------|
| VIT                 | Input threshold voltage   |  |                 |       | 1.4  |       | V    |
| IVODI               | Differential steady-state output voltage magnitude  | $R_L$ = 100 Ω, See Figu                              | 247             |       | 454  | mV    |      |
| Δ V <sub>OD</sub>   | Change in the steady-state differential output voltage magnitude between opposite binary states |  |                 |       | 50   | mV    |      |
| Voc(ss)             | Steady-state common-mode output voltage   | $R_L$ = 100 Ω, See Figur                             | e 3             | 1.125 |      | 1.375 | V    |
| V <sub>OC(PP)</sub> | Peak-to-peak common-mode output voltage   |  |                 |       | 80   | 150   | mV   |
|                     | High level input current  | \/\/a-a  | SN75LVDS84A     |       |      | 20    | ^    |
| ΊΗ                  | High-level input current  | VIH = VCC  | SN65LVDS84AQ    |       |      | 25    | μΑ   |
| I <sub>I</sub> L    | Low-level input current   | V <sub>IL</sub> = 0                                  |                 |       | ±10  | μΑ    |      |
| laa                 | Short-circuit output current  | $V_{O(Yn)} = 0$                                      | $V_{O(Yn)} = 0$ |       | -6   | ±24   | mA   |
| los                 | Short-circuit output current  | $V_{OD} = 0$   |                 |       | -6   | ±12   | mA   |
| loz                 | High-impedance output current   | $V_O = 0$ to $V_{CC}$                                |                 |       |      | ±10   | μΑ   |
|                     |   | Disabled,  | SN75LVDS84A     |       | 15   | 150   | μΑ   |
|                     |   | All inputs at GND                                    | SN65LVDS84AQ    |       | 15   | 170   | μΑ   |
|                     |   | Enabled,<br>R <sub>I</sub> = 100 $\Omega$ (4 places) | f = 65 MHz      |       | 27   | 35    |      |
| ICC(AVG)            | Quiescent supply current (average)  | Gray-scale pattern (see Figure 4)                    | f = 75 MHz      |       | 30   | 38    | mA   |
|                     |   | Enabled,<br>$R_L = 100 \Omega$ , (4 places)          | f = 65 MHz      |       | 28   | 36    | IIIA |
|                     |   | Worst-case pattern (see Figure 5)                    | f = 75 MHz      |       | 31   | 39    |      |
| Cl                  | Input capacitance   |  |                 |       | 2    | ·     | pF   |

 $<sup>^{\</sup>dagger}$  All typical values are at VCC = 3.3 V, TA = 25°C.



# switching characteristics over recommended operating conditions (unless otherwise noted)

|                    | PARAMETER  | TEST CONDITIONS   | MIN                                | TYP <sup>†</sup>   | MAX   | UNIT |
|--------------------|--|---|------------------------------------|--------------------|---|------|
| t <sub>d0</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 0                           |   | -0.2                               |                    | 0.2   |      |
| <sup>t</sup> d1    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 1                           |   | $\frac{1}{7}t_{C} - 0.2$           |                    | $\frac{1}{7}t_{C} + 0.2$                                |      |
| t <sub>d2</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 2                           |   | $\frac{2}{7}t_{C} - 0.2$           |                    | $\frac{\frac{1}{7}t_{C} + 0.2}{\frac{2}{7}t_{C} + 0.2}$ |      |
| t <sub>d3</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 3                           | $t_C$ = 15.38 ns (± 0.2%),<br> Input clock jitter  < 50 ps‡, See Figure 6                               | $\frac{3}{7}t_{C} - 0.2$           |                    | $\frac{3}{7}t_{C} + 0.2$                                | ns   |
| t <sub>d4</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 4                           |   | $\frac{4}{7}t_{C} - 0.2$           |                    | $\frac{4}{7}t_{C} + 0.2$                                |      |
| t <sub>d5</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 5                           |   | $\frac{5}{7}$ t <sub>C</sub> - 0.2 |                    | $\frac{5}{7}$ t <sub>C</sub> + 0.2                      |      |
| t <sub>d6</sub>    | Delay time, CLKOUT <sup>↑</sup> to serial bit position 6                           |   | $\frac{6}{7}t_{C} - 0.2$           |                    | $\frac{6}{7}t_{C} + 0.2$                                |      |
| t <sub>sk(o)</sub> | Output skew, $t_n - \frac{n}{7}t_c$  |   | -0.2                               |                    | 0.2   | ns   |
| ·                  | Delay time CLVINI to CLVOUT  | $t_C$ = 15.38 ns (± 0.2%),<br> Input clock jitter  < 50 ps‡, See Figure 6                               |                                    | 2.7                |   |      |
| <sup>t</sup> d7    | Delay time, CLKIN↓ to CLKOUT↑  | $t_{\rm C}$ = 13.33 ns ~ 32.25 ns (± 0.2%),<br> Input clock jitter  < 50 ps <sup>‡</sup> , See Figure 6 | 1                                  |                    | 4.5   | ns   |
|                    | 2  | $t_{\rm C}$ = 15.38 + 0.308 sin (2 $\pi$ 500E3t) $\pm$ 0.05 ns, See Figure 7                            |                                    | ±62                |   |      |
| $\Delta t_{C(0)}$  | Cycle time, output clock jitter\$  | $t_{C}$ = 15.38 + 0.308 sin (2 $\pi$ 3E6t) $\pm$ 0.05 ns, See Figure 7                                  |                                    | ±121               |   | ps   |
| t <sub>W</sub>     | Pulse duration, high-level output clock  |   |                                    | $\frac{4}{7}t_{C}$ |   | ns   |
| t <sub>t</sub>     | Transition time, differential output voltage $(t_{\Gamma} \text{ or } t_{\Gamma})$ | See Figure 3  |                                    | 700                | 1500  | ps   |
| t <sub>en</sub>    | Enable time, SHTDN↑ to phase lock (Yn valid)                                       | See Figure 8  |                                    | 1                  |   | ms   |
| <sup>t</sup> dis   | Disable time, SHTDN↓ to off state (CLKOUT low)                                     | See Figure 9  |                                    | 6.5                |   | ns   |

<sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C. ‡ |Input clock jitter| is the magnitude of the change in the input clock period.

<sup>§</sup> Output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 15000 cycles.

#### PARAMETER MEASUREMENT INFORMATION

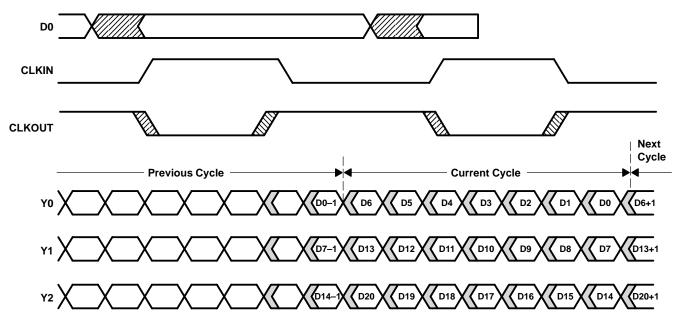
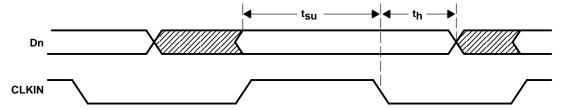
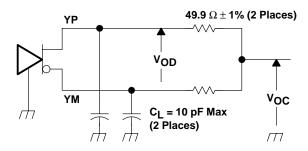


Figure 1. Typical Load and Shift Sequences



NOTE A: All input timing is defined at 1.4 V on an input signal with a 10%-to-90% rise or fall time of less than 5 ns.

Figure 2. Setup and Hold Time Definition

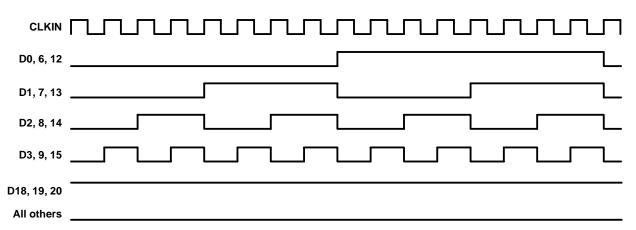


NOTE A: The lumped instrumentation capacitance for any single-ended voltage measurement is less than or equal to 10 pF. When making measurements at YP or YM, the complementary output is similarly loaded.

# (a) SCHEMATIC 100% 80% VOD(H) VOD(L) VOC(PP) VOC(SS) VOC(SS) VOC(SS) O V

Figure 3. Test Load and Voltage Definitions for LVDS Outputs

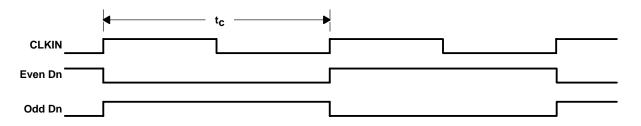




NOTES: A. The 16-grayscale test-pattern test device power consumption for a typical display pattern.

B.  $V_{IH} = 2 V$  and  $V_{IL} = 0.8 V$ 

Figure 4. 16-Grayscale Test-Pattern Waveforms



NOTES: A. The worst-case test pattern produces nearly the maximum switching frequency for all of the LVDS outputs.

B.  $V_{IH} = 2 V$  and  $V_{IL} = 0.8 V$ 

Figure 5. Worst-Case Test-Pattern Waveforms

# t<sub>d7</sub> **CLKIN** CLKOUT t<sub>d</sub>0 t<sub>d1</sub> t<sub>d2</sub> t<sub>d3</sub> t<sub>d4</sub> t<sub>d5</sub> t<sub>d6</sub> V<sub>OD(H)</sub> CLKOUT **CLKIN** 1.4 V or Υn V<sub>OD(L)</sub> t<sub>d7</sub> td0 - td6 **Figure 6. Timing Definitions** Device Reference vco Under Test Modulation $V(t) = A \sin (2 \pi f_{(mod)} t)$ HP8665A HP8133A **Device Under Test** Tek TDS794D Synthesized **Pulse Generator Digital Scope** Signal Generator 0.1 MHz - 4200 MHz **OUTPUT CLKIN CLKOUT** Input

PARAMETER MEASUREMENT INFORMATION

Figure 7. Clock Jitter Test Setup

**RF Output** 

Ext. Input

#### TYPICAL CHARACTERISTICS

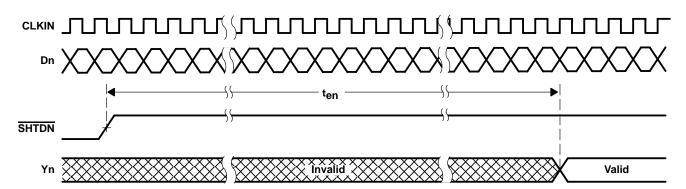


Figure 8. Enable Time Waveforms

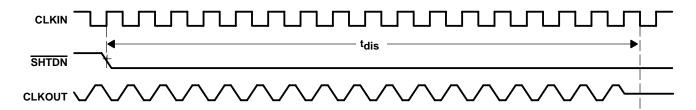


Figure 9. Disable Time Waveforms

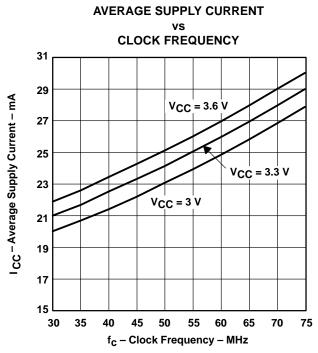


Figure 10. Grayscale Input Pattern

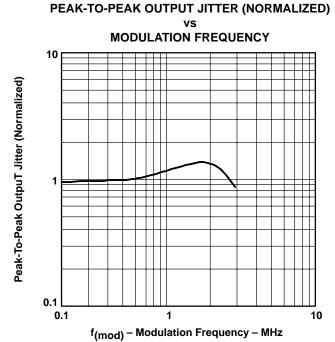
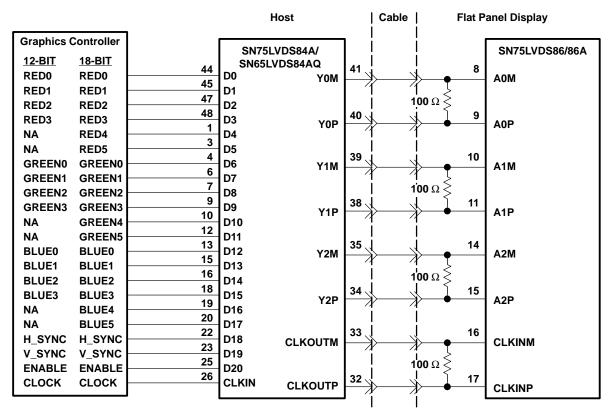


Figure 11. Output Period Jitter vs Modulation Frequency

#### **APPLICATION INFORMATION**

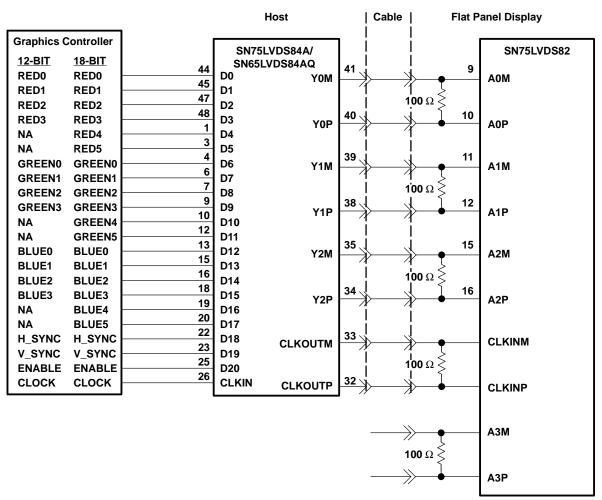


NOTES: A. The five  $100-\Omega$  terminating resistors are recommended to be 0603 types.

B. NA – not applicable, these unused inputs should be left open.

Figure 12. Color Host to LCD Panel Application

#### APPLICATION INFORMATION



NOTES: A. The four 100- $\Omega$  terminating resistors are recommended to be 0603 types.

B. NA – not applicable, these unused inputs should be left open.

Figure 13. 18-Bit Color Host to 24-Bit LCD Display Panel Application

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#### PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins   | Package qty   Carrier | RoHS | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|------------------|-----------------------|------|-------------------------------|----------------------------|--------------|--------------|
|                       | (1)    | (2)           |                  |                       | (3)  | (4)                           | (5)                        |              | (6)          |
| SN65LVDS84AQDGG       | Active | Production    | TSSOP (DGG)   48 | 40   TUBE             | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 65LVDS84AQ   |
| SN65LVDS84AQDGG.A     | Active | Production    | TSSOP (DGG)   48 | 40   TUBE             | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 65LVDS84AQ   |
| SN65LVDS84AQDGGR      | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 65LVDS84AQ   |
| SN65LVDS84AQDGGR.A    | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 65LVDS84AQ   |
| SN75LVDS84ADGG        | Active | Production    | TSSOP (DGG)   48 | 40   TUBE             | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |
| SN75LVDS84ADGG.A      | Active | Production    | TSSOP (DGG)   48 | 40   TUBE             | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |
| SN75LVDS84ADGGR       | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |
| SN75LVDS84ADGGR.A     | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |
| SN75LVDS84ADGGRG4     | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |
| SN75LVDS84ADGGRG4.A   | Active | Production    | TSSOP (DGG)   48 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-2-260C-1 YEAR        | 0 to 70      | SN75LVDS84A  |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



# PACKAGE OPTION ADDENDUM

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

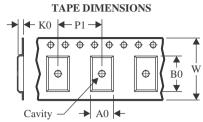
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





|    | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device            | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|-------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN65LVDS84AQDGGR  | TSSOP           | DGG                | 48 | 2000 | 330.0                    | 24.4                     | 8.6        | 13.0       | 1.8        | 12.0       | 24.0      | Q1               |
| SN75LVDS84ADGGR   | TSSOP           | DGG                | 48 | 2000 | 330.0                    | 24.4                     | 8.6        | 13.0       | 1.8        | 12.0       | 24.0      | Q1               |
| SN75LVDS84ADGGRG4 | TSSOP           | DGG                | 48 | 2000 | 330.0                    | 24.4                     | 8.6        | 13.0       | 1.8        | 12.0       | 24.0      | Q1               |

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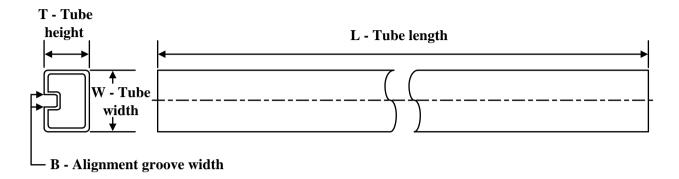
#### \*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN65LVDS84AQDGGR  | TSSOP        | DGG             | 48   | 2000 | 350.0       | 350.0      | 43.0        |
| SN75LVDS84ADGGR   | TSSOP        | DGG             | 48   | 2000 | 350.0       | 350.0      | 43.0        |
| SN75LVDS84ADGGRG4 | TSSOP        | DGG             | 48   | 2000 | 350.0       | 350.0      | 43.0        |

# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**

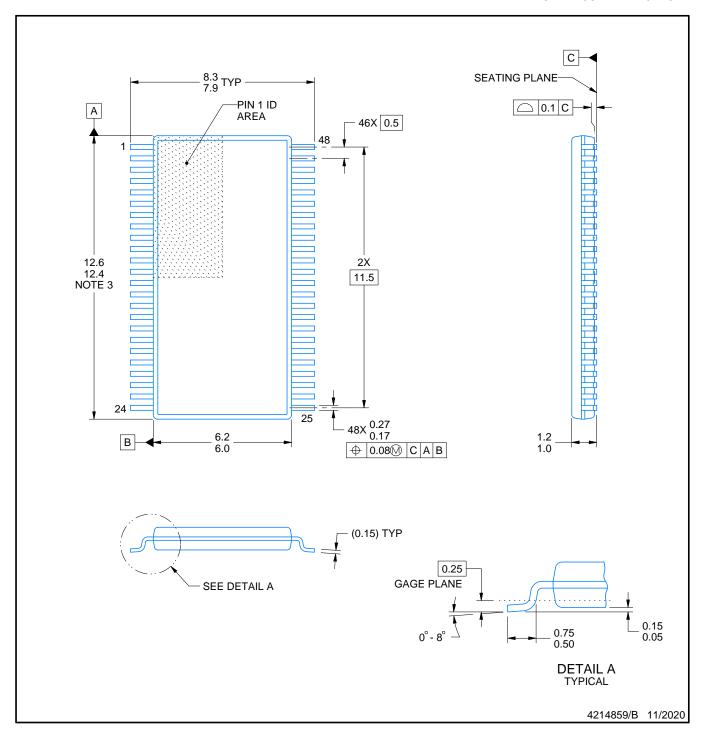


\*All dimensions are nominal

| Device            | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|-------------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| SN65LVDS84AQDGG   | DGG          | TSSOP        | 48   | 40  | 530    | 11.89  | 3600   | 4.9    |
| SN65LVDS84AQDGG.A | DGG          | TSSOP        | 48   | 40  | 530    | 11.89  | 3600   | 4.9    |
| SN75LVDS84ADGG    | DGG          | TSSOP        | 48   | 40  | 530    | 11.89  | 3600   | 4.9    |
| SN75LVDS84ADGG.A  | DGG          | TSSOP        | 48   | 40  | 530    | 11.89  | 3600   | 4.9    |



SMALL OUTLINE PACKAGE



#### NOTES:

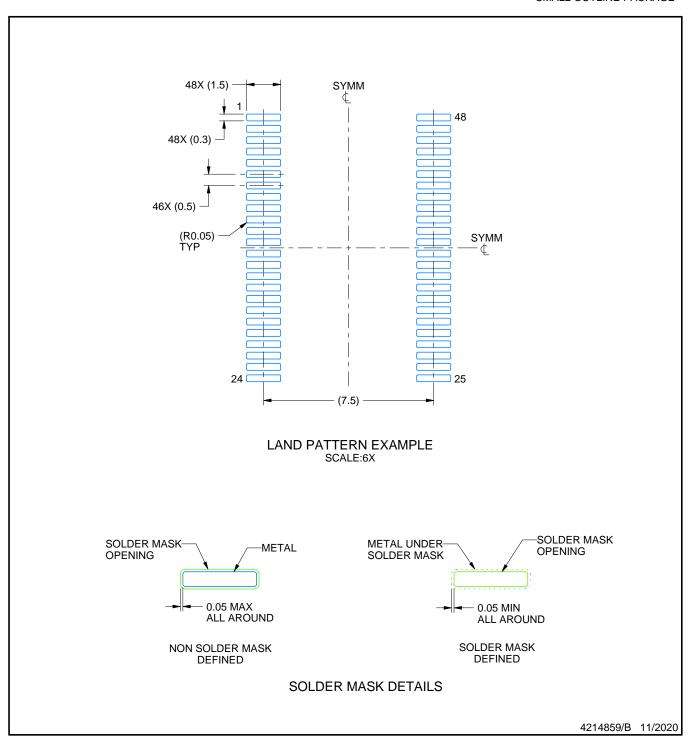
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE

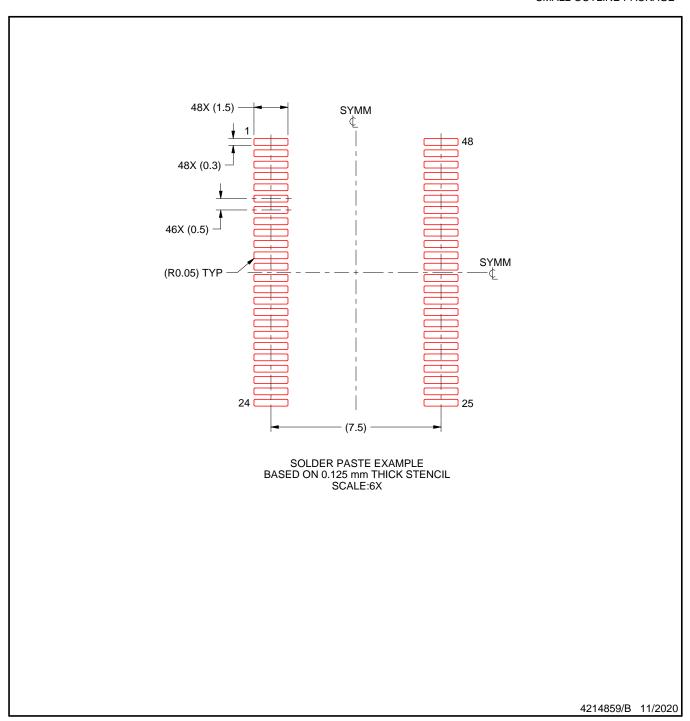


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

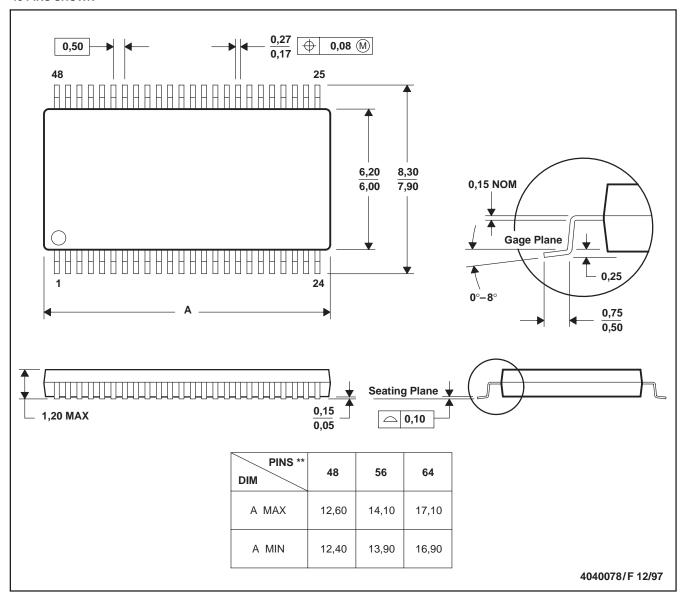
- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



# DGG (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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